

# Index of Claims



Application/Control No.

10/047,717

Examiner

Tan Dean D. Nguyen

Applicant(s)/Patent under Reexamination

KNAPP, RICHARD J.

Art Unit

3629

✓	Rejected
=	Allowed

-	(Through numeral) Cancelled
+	Restricted

N	Non-Elected
I	Interference

A	Appeal
O	Objected

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